

**Search Notes**

Application/Control No.

10/657,331

Examiner

Daniel Pan

Applicant(s)/Patent under  
Reexamination

MOYER, WILLIAM C.

Art Unit

2183

**SEARCHED**

Class	Subclass	Date	Examiner
712	4 22 27 225	9/4/2007	DP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
712	4 22 27 225	9/4/2007	DP
Interference searched on west PGP		9/4/2007	DP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
west pgg uspat jpoabs derwent IBM TD IEEE NPL 710/52,60 712/227,300 711/171-173	9/4/2007	DP